

XP131A1330SR

ETR1103_001

Power MOSFET

GENERAL DESCRIPTION

The XP131A1330SR is an N-channel Power MOSFET with low on-state resistance and ultra high-speed switching characteristics

Because high-speed switching is possible, the IC can be efficiently set thereby saving energy.

The small SOP-8 package makes high density mounting possible.

APPLICATIONS

Notebook PCs

Cellular and portable phones

On-board power supplies

Li-ion battery systems

FEATURES

Low On-State Resistance: Rds(on)=0.03 (Vgs=4.5V)
 : Rds(on)=0.04 (Vgs=2.5V)
 : Rds(on)=0.07 (Vgs=1.5V)

Ultra High-Speed Switching

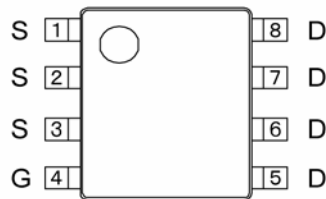
Driving Voltage : 1.5V

N-Channel Power MOSFET

DMOS Structure

Package : SOP-8

PIN CONFIGURATION

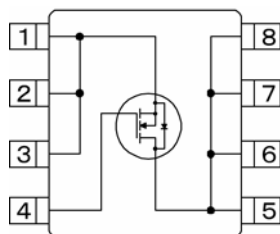


SOP-8
(TOP VIEW)

PIN ASSIGNMENT

| PIN NUMBER | PIN NAME | FUNCTION |
|------------|----------|----------|
| 1~3 | S | Source |
| 4 | G | Gate |
| 5~8 | D | Drain |

EQUIVALENT CIRCUIT



N-channel MOSFET
(1 device built-in)

ABSOLUTE MAXIMUM RATINGS

Ta = 25°C

| PARAMETER | SYMBOL | RATINGS | UNITS |
|-----------------------------|--------|---------|-------|
| Drain-Source Voltage | Vdss | 20 | V |
| Gate-Source Voltage | Vgss | ± 8 | V |
| Drain Current (DC) | Id | 8 | A |
| Drain Current (Pulse) | Idp | 30 | A |
| Reverse Drain Current | Idr | 8 | A |
| Channel Power Dissipation * | Pd | 2.5 | W |
| Channel Temperature | Tch | 150 | |
| Storage Temperature Range | Tstg | -55~150 | |

* When implemented on a glass epoxy PCB

ELECTRICAL CHARACTERISTICS

DC Characteristics

Ta = 25°C

| PARAMETER | SYMBOL | CONDITIONS | MIN. | TYP. | MAX. | UNITS |
|------------------------------------|----------------------|---|------|-------|-------|-------|
| Drain Cut-Off Current | I _{dss} | V _{ds} =20V, V _{gs} =0V | - | - | 10 | μA |
| Gate-Source Leak Current | I _{gss} | V _{gs} = ± 8V, V _{ds} =0V | - | - | ± 1 | μA |
| Gate-Source Cut-Off Voltage | V _{gs(off)} | I _d =1mA, V _{ds} =10V | 0.5 | - | 1.2 | V |
| Drain-Source On-State Resistance * | R _{ds(on)} | I _d =4A, V _{gs} =4.5V | - | 0.025 | 0.03 | |
| | | I _d =4A, V _{gs} =2.5V | - | 0.030 | 0.040 | |
| | | I _d =1A, V _{gs} =1.5V | - | 0.045 | 0.07 | |
| Forward Transfer Admittance * | Y _{fs} | I _d =4A, V _{ds} =10V | - | 22 | - | S |
| Body Drain Diode Forward Voltage | V _f | I _f =8A, V _{gs} =0V | - | 0.85 | 1.1 | V |

* Effective during pulse test.

Dynamic Characteristics

Ta = 25°C

| PARAMETER | SYMBOL | CONDITIONS | MIN. | TYP. | MAX. | UNITS |
|----------------------|------------------|---|------|------|------|-------|
| Input Capacitance | C _{iss} | V _{ds} =10V, V _{gs} =0V f=1MHz | - | 950 | - | pF |
| Output Capacitance | C _{oss} | | - | 430 | - | pF |
| Feedback Capacitance | C _{rss} | | - | 180 | - | pF |

Switching Characteristics

Ta = 25°C

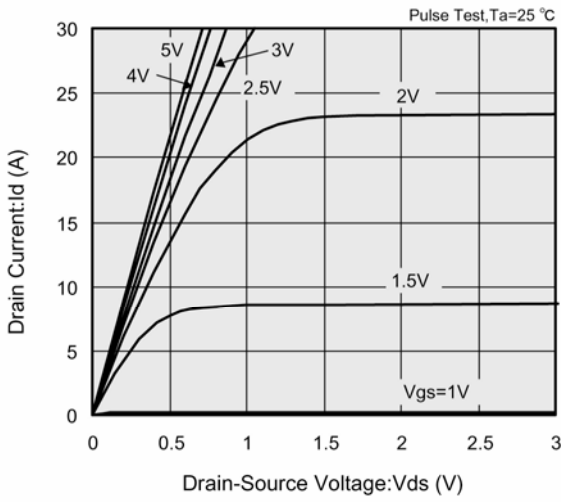
| PARAMETER | SYMBOL | CONDITIONS | MIN. | TYP. | MAX. | UNITS |
|---------------------|----------------------|---|------|------|------|-------|
| Turn-On Delay Time | t _{d (on)} | V _{gs} =5V, I _d =4A V _{dd} =10V | - | 15 | - | ns |
| Rise Time | t _r | | - | 20 | - | ns |
| Turn-Off Delay Time | t _{d (off)} | | - | 80 | - | ns |
| Fall Time | t _f | | - | 15 | - | ns |

Thermal Characteristics

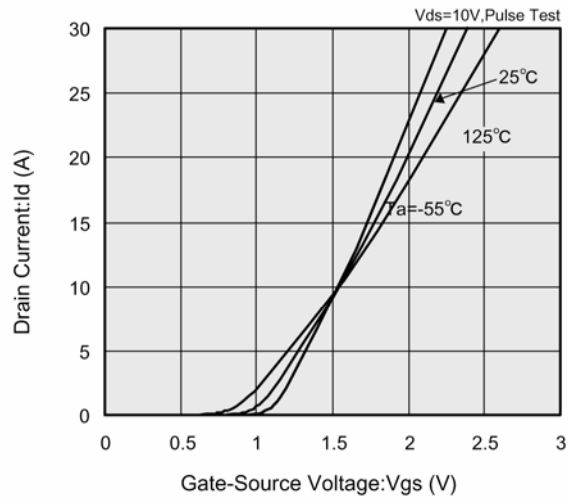
| PARAMETER | SYMBOL | CONDITIONS | MIN. | TYP. | MAX. | UNITS |
|---------------------------------------|------------------------|--------------------------------------|------|------|------|-------|
| Thermal Resistance (Channel-Ambience) | R _{th (ch-a)} | Implement on a glass epoxy resin PCB | - | 50 | - | /W |

TYPICAL PERFORMANCE CHARACTERISTICS

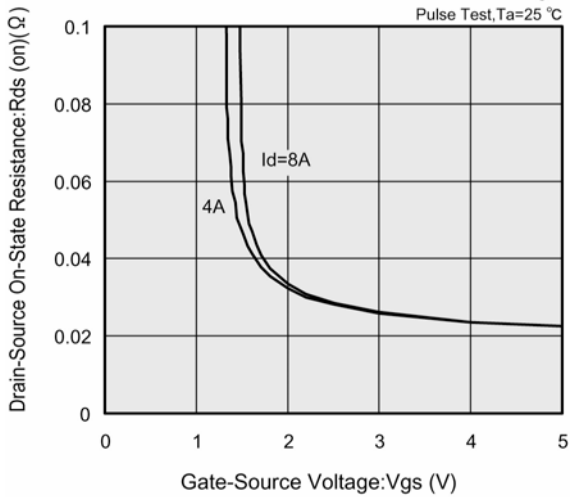
(1) Drain Current vs. Drain-Source Voltage



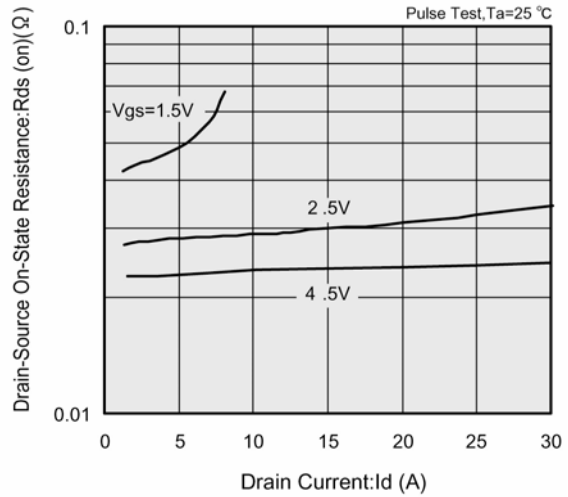
(2) Drain Current vs. Gate-Source Voltage



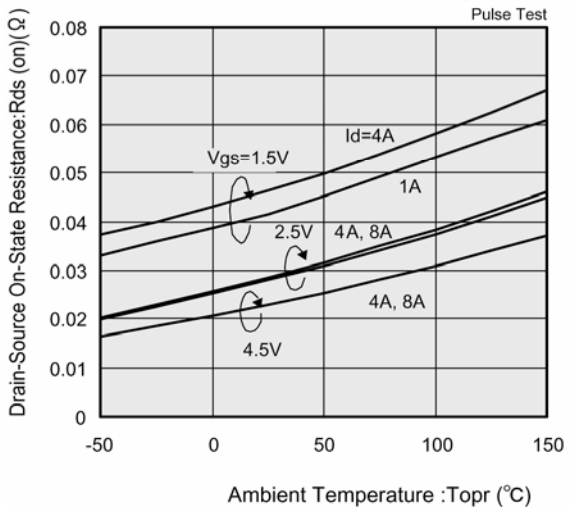
(3) Drain-Source On-State Resistance vs. Gate-Source Voltage



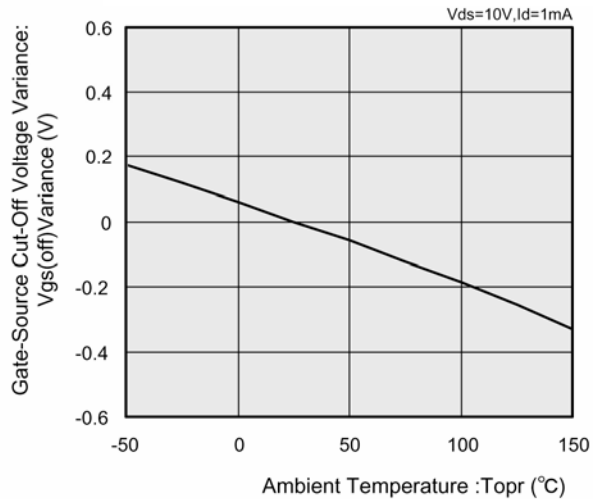
(4) Drain-Source On-State Resistance vs. Drain Current



(5) Drain-Source On-State Resistance vs. Ambient Temperature

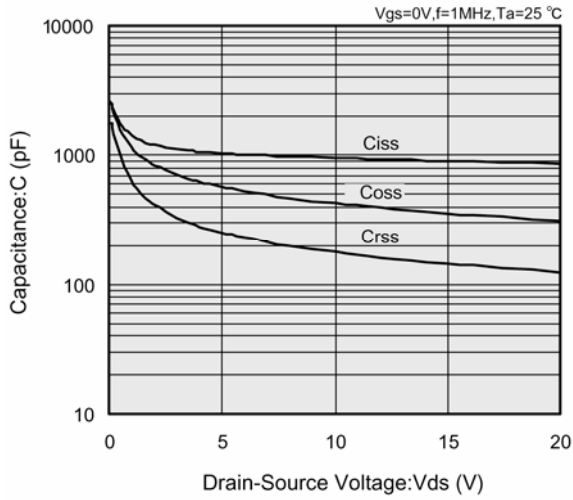


(6) Gate-Source Cut-Off Voltage Variance vs. Ambient Temperature

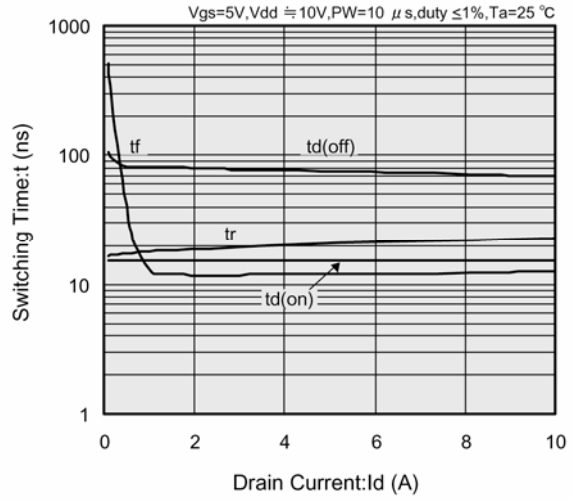


TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

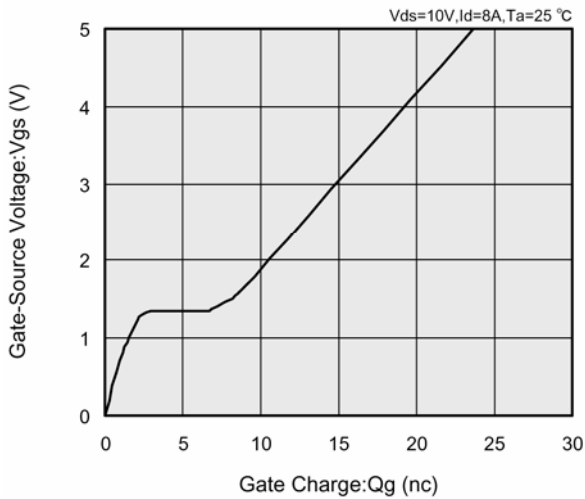
(7) Capacitance vs. Drain-Source Voltage



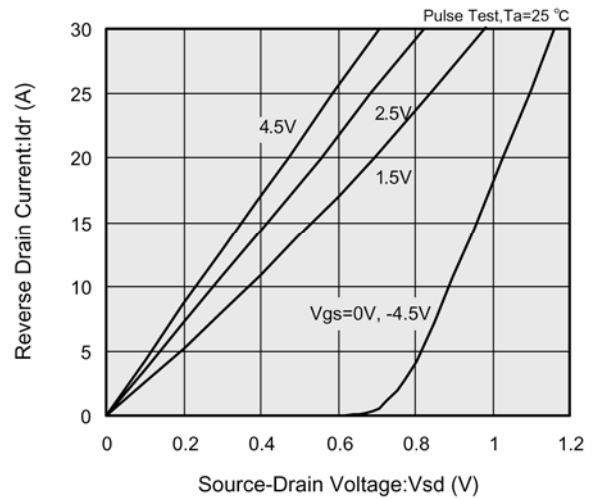
(8) Switching Time vs. Drain Current



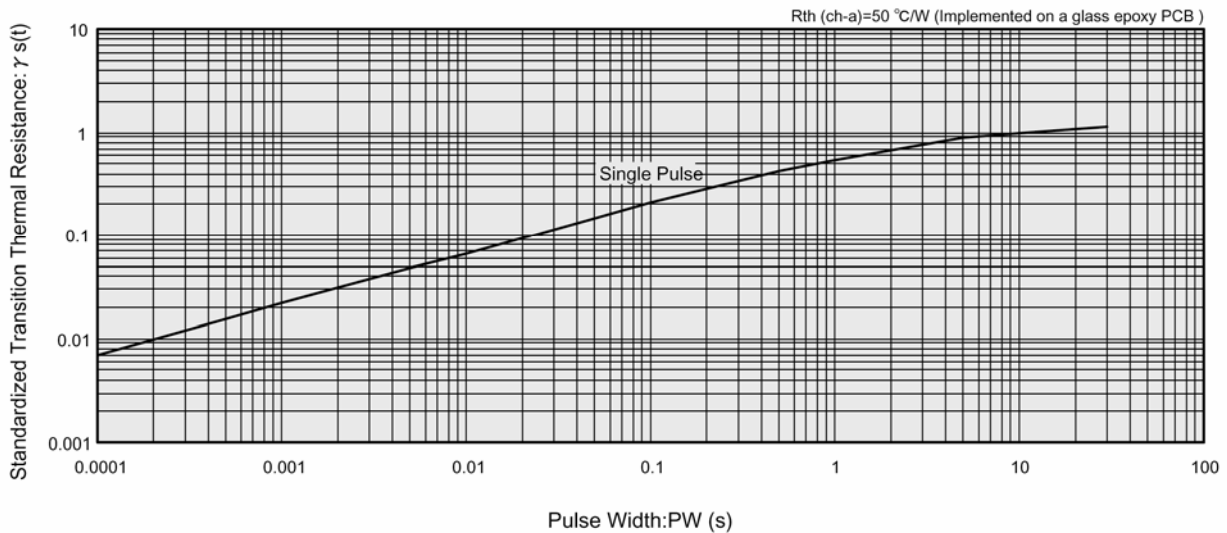
(9) Gate-Source Voltage vs. Gate Charge



(10) Reverse Drain Current vs. Source-Drain Voltage



(11) Standardized transition Thermal Resistance vs. Pulse Width



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